

**LIST OF ART CITED BY APPLICANT**  
(PTO-1449)ATTY. DOCKET NO.  
**IK-0086**APPLN. SERIAL NO.  
**10/801,566**APPLICANT(S)  
**Yong-Chol KWON**FILING DATE  
**March 17, 2004**GROUP  
**3744****U.S. PATENT DOCUMENTS**

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE
	<b>5,520,453</b>	<b>05/28/1996</b>	<b>Aoki et al.</b>	<b>312</b>	<b>406</b>	<b>08/10/1994</b>

**U.S. PATENT APPLICATION PUBLICATIONS**

	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	

**U.S. PATENT APPLICATIONS**

	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	

**FOREIGN PATENT DOCUMENTS**

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
	<b>WO 03/023298</b>	<b>03/20/2003</b>	<b>WIPO (Full English Text)</b>			<b>X</b>	
	<b>GB 2 186 311</b>	<b>080/12/1987</b>	<b>United Kingdom (Full English Text)</b>			<b>X</b>	

**OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)**


EXAMINER

DATE CONSIDERED

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

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